TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MZ138FK

Low Voltage 3-to-8 Line Decoder with 5 V Tolerant Inputs and Outputs

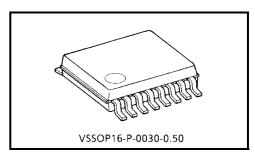
The TC7MZ138FK is a high performance CMOS 3-to-8 decoder. Designed for use in 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) $V_{\rm CC}$ applications, but it could be used to interface to 5 V supply environment for inputs.

When the device is enabled, 3 binary select inputs (A, B and C) determine which one of the outputs $(\overline{Y}0 - \overline{Y}7)$ will go low.

When enable input G1 is held low or either $\overline{G}2A$ or $\overline{G}2B$ is held high, decoding function is inhibited and all outputs go high. G1, $\overline{G}2A$, and $\overline{G}2B$ inputs are provided to ease cascade connection and for use as an address decoder for memory systems.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.02 g (typ.)

Features

- Low voltage operation: $VCC = 2.0 \sim 3.6 \text{ V}$
- High speed operation: $t_{pd} = 6.0 \text{ ns (max)} (V_{CC} = 3.0 \sim 3.6 \text{ V})$
- Output current: $|I_{OH}|/I_{OL} = 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: ±500 mA
- Package: VSSOP (US16)
- · Power down protection is provided on all inputs and outputs.
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 138 type.

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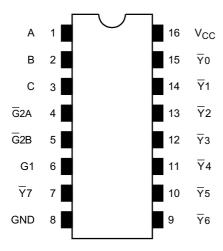
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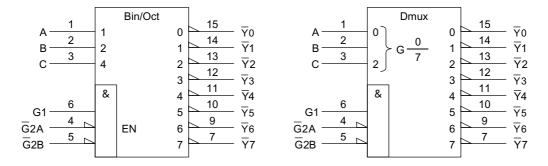
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Pin Assignment (top view)



IEC Logic Symbol



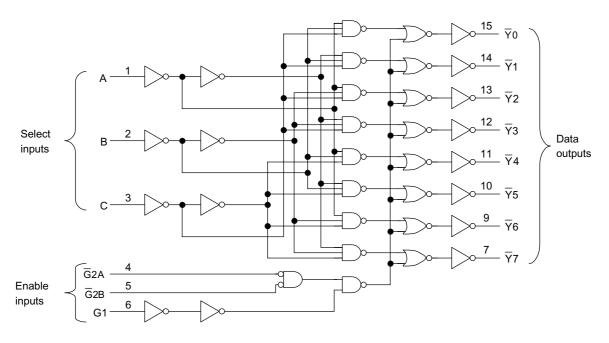
Truth Table

	Inputs					Outputs								
Enable		Select		₹0	<u>7</u> 1	_ Y2	- <u>7</u> 3	<u></u>	_ Y5	<u>7</u> 6	<u>7</u> 7	Selected Output		
G1	G ₂ A	G ₂ B	С	В	Α	10		12	13	14	1	1	17	
L	Х	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н	None
Х	Н	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н	None
Х	Х	Н	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н	None
Н	L	L	L	L	L	L	Н	Н	Н	Н	Н	Н	Н	₩ Y0
Н	L	L	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	₹1
Н	L	L	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н	₹2
Н	L	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	7 3
Н	L	L	Н	L	L	Н	Н	Н	Н	L	Н	Н	Н	Y 4
Н	L	L	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н	Y5
Н	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Y 6
Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Ÿ7

X: Don't care



System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit	
Supply voltage range	V _{CC}	-0.5~7.0	V	
DC input voltage	V _{IN}	-0.5~7.0	V	
DC output voltage	Vout	-0.5~7.0 (Note1)	V	
DC output voltage	VOUT	-0.5~V _{CC} + 0.5 (Note2)	V	
Input diode current	I _{IK}	-50	mA	
Output diode current	lok	±50 (Note3)	mA	
DC output current	Гоит	±50	mA	
Power dissipation	P _D	180	mW	
DC V _{CC} /ground current	I _{CC} /I _{GND}	±100	mA	
Storage temperature	T _{stg} –65~150		°C	

Note1: $V_{CC} = 0 V$

Note2: High or low state. $I_{\mbox{\scriptsize OUT}}$ absolute maximum rating must be observed.

Note3: $V_{OUT} < GND, V_{OUT} > V_{CC}$



Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit		
Supply voltage	V _{CC}	2.0~3.6	V		
Supply voltage	VCC	1.5~3.6 (Note4)	V		
Input voltage	V _{IN}	0~5.5	V		
Output voltage	Vout	0~5.5 (Note5)	V		
Output voltage	V _{OUT} 0~V _{CC} (Note6)				
Output current	I _{OH} /I _{OI}	±24 (Note7)	mA		
Output current	IOH/IOL	±12 (Note8)	IIIA		
Operating temperature	T _{opr}	-40~85	°C		
Input rise and fall time	dt/dv	0~10 (Note9)	ns/V		

Note4: Data retention only

Note5: $V_{CC} = 0 V$

Note6: High or low state Note7: $V_{CC} = 3.0 \sim 3.6 \text{ V}$ Note8: $V_{CC} = 2.7 \sim 3.0 \text{ V}$

Note9: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$

Electrical Characteristics

DC Characteristics ($Ta = -40 \sim 85$ °C)

Characteristics		Symbol	Test Condition				Max	Unit
Onaracio	21131103	Cymbol		cst condition	V _{CC} (V)	Min	IVICA	Onic
land to the sec	High level	V _{IH}	_		2.7~3.6	2.0	_	V
Input voltage	Low level	V _{IL}		_	2.7~3.6	_	0.8	V
	High level	V _{ОН}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OH} = -100 μA	2.7~3.6	V _{CC} - 0.2	_	V
				$I_{OH} = -12 \text{ mA}$	2.7	2.2	_	
				$I_{OH} = -18 \text{ mA}$	3.0	2.4	_	
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	
	Low level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 100 \mu A$	2.7~3.6	_	0.2	
				$I_{OL} = 12 \text{ mA}$	2.7	_	0.4	
				$I_{OL} = 16 \text{ mA}$	3.0	_	0.4	
				$I_{OL} = 24 \text{ mA}$	3.0	_	0.55	
Input leakage cu	Input leakage current		V _{IN} = 0~5.5 V		2.7~3.6	_	±5.0	μΑ
Power off leakage current		I _{OFF}	$V_{IN}/V_{OUT} = 5.5 V$	0	_	10.0	μΑ	
Quiescent supply current		Icc	$V_{IN} = V_{CC}$ or GND	2.7~3.6	_	10.0		
		100	V _{IN} = 3.6~5.5 V	2.7~3.6	—	±10.0	μΑ	
Increase in I _{CC}	per input	Δl _{CC}	$V_{IH} = V_{CC} - 0.6 V$	2.7~3.6	_	500		



AC Characteristics ($Ta = -40 \sim 85$ °C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.7	_	7.0	ne
(A, B, C- \overline{Y})	t _{pHL}	rigure 1, rigure 2	3.3 ± 0.3	1.5	6.0	ns
Propagation delay time	t _{pLH}	Figure 1 Figure 2	2.7		8.0	ns
(G1- \overline{Y})	G1-Y) Figure 1, Figure 2		3.3 ± 0.3	1.5	7.0	113
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.7	_	7.0	ns
(G 2 - Y)	t _{pHL}	rigure 1, rigure 2	3.3 ± 0.3	1.5	6.0	110
Output to output skew	t _{osLH}	(Note10)	2.7	_		
Output to output skew	t _{osHL}	(Note 10)	3.3 ± 0.3	_	1.0	ns

Note10: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, Input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ Ω)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V _{OL}	V_{OLP}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	_	3.3	7	pF
Output capacitance	C _{OUT}	_	0	8	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note11) 3.3	25	pF

Note11: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

ICC (opr) = CPD· VCC· fIN + ICC

AC Test Circuit

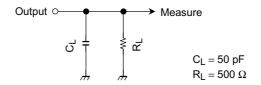


Figure 1

AC Waveform

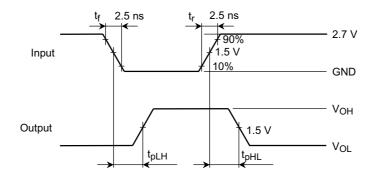
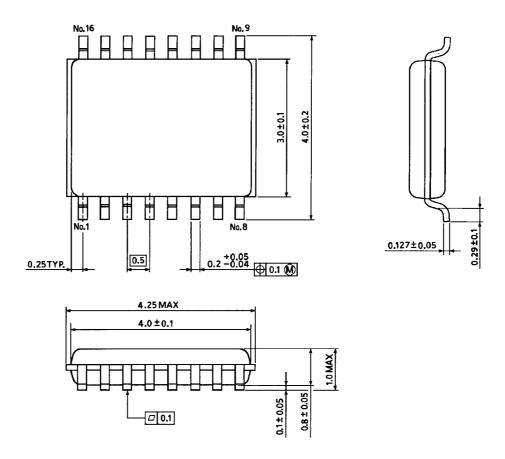


Figure 2 t_{pLH} , t_{pHL}

Package Dimensions



Weight: 0.02 g (typ.)